

<b>Notice of References Cited</b>	Application/Control No. 10/004,713	Applicant(s)/Patent Under Reexamination FARKASH, RON H.	
	Examiner Julian Mercado	Art Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,124,478	11-1978	Tsien et al.	204/255
	B	US-5,543,240	08-1996	Lee et al.	429/38
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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